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Application/Control No.	Applicant(s)/Patent under Reexamination
10/777,996	TAJIMA ET AL.
Examiner	Art Unit

Tuan A. Tran

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Class	Subclass	Date		Examiner	
455	3.01	8/16/2006		TT	
455	3.05-06				
455	556.1-2				
455	575.1,9				
455	90.1-3				
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST (USPAT, USPGPUB, USOCR, JPO, EPO, DERWENT)	8/16/2006	тт
EAST (USPAT, USPGPUB, USOCR, JPO, EPO, DERWENT) updating search	7/17/2007	П
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